



# UNITED STATES PATENT AND TRADEMARK OFFICE



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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/833,953	04/11/2001	Marco Racanelli	00CON161P	3823
75	03/07/2002			
FARJAMI & FARJAMI LLP 16148 Sand Canyon Irvine, CA 92618			EXAMINER	
			MALDONADO, JULIO J	
			ART UNIT	PAPER NUMBER
			2823 DATE MAILED: 03/07/2002	#2

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	plicant(s)			
		09/833,953	RACANELLI, MARCO			
•	Office Action Summary	Examiner	Art Unit			
		Julio J. Maldonado	2823			
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the	correspondence address			
A SH THE I - Exte after - If the - If NO - Failu - Any	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. Insions of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. It is period for reply specified above is less than thirty (30) days, a reply operiod for reply is specified above, the maximum statutory period to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing end patent term adjustment. See 37 CFR 1.704(b)	36(a). In no event, however, may a reply be so within the statutory minimum of thirty (30) divill apply and will expire SIX (6) MONTHS fro cause the application to become ABANDON	imely filed  ays will be considered timely  m the mailing date of this communication  ED (35 U S C. § 133).			
1)[	Responsive to communication(s) filed on 11 A	April 2001 .				
2a)☐		is action is non-final.				
3)	Since this application is in condition for allowa	ance except for formal matters,	prosecution as to the merits is			
•	closed in accordance with the practice under ion of Claims		453 O.G. 213.			
4)[	Claim(s) 1-25 is/are pending in the application					
_	4a) Of the above claim(s) is/are withdrawn from consideration.					
·	Claim(s) is/are allowed.					
•	Claim(s) <u>1-25</u> is/are rejected.					
•	Claim(s) <u>1, 9, 12, 20 and 23</u> is/are objected to					
	Claim(s) are subject to restriction and/c	r election requirement.				
• •	ion Papers  The enceitigation is objected to by the Evamine	ar.				
. —	The specification is objected to by the Examine The drawing(s) filed on is/are: a) ☐ acce		aminer			
10)[	Applicant may not request that any objection to the					
11)[]	The proposed drawing correction filed on					
,	If approved, corrected drawings are required in re					
12) The oath or declaration is objected to by the Examiner.						
Priority	under 35 U.S.C. §§ 119 and 120					
13)	Acknowledgment is made of a claim for foreig	n priority under 35 U.S.C. § 119	(a)-(d) or (f).			
	) All b) Some * c) None of:					
	1. Certified copies of the priority documen	ts have been received.				
	2. Certified copies of the priority documen	ts have been received in Applica	ation No			
* ;	3. Copies of the certified copies of the price application from the International Buse the attached detailed Office action for a list	ireau (PCT Rule 17.2(a)).				
	Acknowledgment is made of a claim for domest					
á	a)  The translation of the foreign language process. Acknowledgment is made of a claim for domes	ovisional application has been re	eceived.			
Attachme		-				
1) Noti	ice of References Cited (PTO-892) ice of Draftsperson's Patent Drawing Review (PTO-948) rmation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Inform	ary (PTO-413) Paper No(s)			



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#### **DETAILED ACTION**

### Claim Objections

1. Claims 1, 9, 12, 20 and 23 objected to because of the following informalities: in claim 1 says "...forming a transistor gate and a field oxide <u>region</u>; doping with a first dopant said layer over said transistor gate \_\_ without..." should say "...forming a transistor gate and a field oxide <u>regions</u>; doping with a first dopant said layer over said transistor gate <u>regions</u> without...". In claims 9 and 20 says "...approximately  $6.5 \pm 10^{15}$ ..." should say "...approximately  $6.5 \pm 10^{15}$ ..." In claims 12 and 23 says "...approximately  $1.0 \pm 10^{15}$ ..." should say "...approximately  $1.0 \pm 10^{15}$ ..." Appropriate correction is required.

## Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1, 3, 6-12, 14-23 rejected under 35 U.S.C. 102(b) as being anticipated by Zaccherini (U.S. 5,436,177).

In reference to claim 1 and 14 Zaccherini (Fig.1-6) teaches an analogous method to form implanted regions including the steps of forming a layer (7) comprising polycrystalline silicon over a transistor gate (4) and a field oxide (5) regions; forming a doping barrier (10) above said polycrystalline silicon; doping with a first dopant (11) said

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layer over said transistor gate without doping said layer over said field oxide region (5); removing said doping barrier (10); doping said layer over said transistor gate (4) and said field oxide regions (5) with a second dopant (13) so as to form a resistor in said layer (7) over said field oxide region (5).

In reference to claim 3, 6-12 and 15-23 Zaccherini teaches that said layer (7) comprises polysilicon; that said field oxide (5) comprises silicon oxide; that first dopant (11) is an N-type dopant comprising phosphorous at a dose of approximately 6.5x10<sup>15</sup> atoms per square centimeter; that the second dopant is a P-type dopant comprising boron at a dose of approximately 1.0x10<sup>15</sup> atoms per square centimeter; and that said doping barrier (10) comprises a photoresist; that the polycrystalline silicon layer includes a gate region (4).

### Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claim 2, 4-5, 13 and 24-25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Zaccherini ('177) in view Liu et al. (U.S. 6,165,861).

In reference to claims 2, 4-5, 13 and 24-25 Zaccherini teaches all aspects of the invention but fails to teach the formation of a contact region for said resistor comprising a silicide. Nevertheless, Liu et al. (Fig.7) teaches in an analogous method for forming integrated resistors including a contact region comprising a titanium silicide (20).

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Furthermore, Liu et al. teaches that the transistor gate can be a gate of a PFET or a gate of a NFET (column 4, lines 11-24).

Therefore, it would have been obvious to one of basic skill in the art to combine the teachings of Zaccherini and Liu et al. to arrive the claimed invention. The motivation/suggestion would be to make interconnections to other levels within the circuit and providing shielding of the resistor during subsequent processing (column 4, lines 25-41). Furthermore, it would have been obvious to one skilled in the art that by using additional masking steps, both PFET and NFET can be made into the substrate (column 4, lines 11-24).

#### Conclusion

- 5. Papers related to this application may be submitted directly to Art Unit 2823 by facsimile transmission. Papers should be faxed to Art Unit 2823 via the Art Unit 2823 Fax Center located in Crystal Plaza 4, room 3C23. The faxing of such papers must conform to the notice published in the Official Gazette, 1096 OG 30 (15 November 1989). The Art Unit 2823 Fax Center number is (703) 305-3432. The Art Unit 2823 Fax Center is to be used only for papers related to Art Unit 2823 applications.
- 6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to **Julio J. Maldonado** at **(703)** 306-0098 and between the hours of 8:00 AM to 4:00 PM (Eastern Standard Time) Monday through Friday or by e-mail via julio.maldonado@uspto.gov. If attempts to reach the examiner by telephone

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are unsuccessful, the examiner's supervisor, Wael Fahmy, can be reached on (703) 308-4918.

- 7. Any inquiry of a general nature or relating to the status of this application should be directed to the **Group 2800 Receptionist** at **(703) 308-0956**.
- 8. The following list is the Examiner's field of search for the present Office Action:

U.S. Class / Subclass(es): 438/382, 438/385	02/25/2002
Other Documentation:	
Electronic Database(s): EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM)	02/25/2002

Julio J. Maldonado

Patent Examiner Art Unit 2823 703-306-0098

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